Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,495	KIME ET AL.	
Examiner	Art Unit	
Minh Dieu Nauven	2137	

	SEARCHED			
Class	Subclass	Date	Examiner	
726	22-23, 29	8/9/2006	MDN	
709	224-226	8/9/2006	MDN	
455	404.1,410	8/9/2006	MDN	
455	404.2,411	8/9/2006	MDN	
455	456.1-457	8/9/2006	MDN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Inventor name search on EAST (US- PAT; US-PGPUB; DERWENT; IBM- TDB; EPO; JPO)	8/9/2006	MDN
Text and class search on EAST (US-PAT; US-PGPUB; DERWENT; IBM-TDB; EPO; JPO)	8/9/2006	MDN
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